

Constraining the value of the dielectric constant of the ferroelectric nematic phase

Aitor Erkoreka* and Josu Martinez-Perdiguero

*Department of Physics, Faculty of Science and Technology,
University of the Basque Country UPV/EHU, Bilbao, Spain*

(Dated: May 13, 2024)

Abstract

Ferroelectric nematic liquid crystals are currently being subject to a plethora of investigations since they are of great fundamental interest and could potentially foster promising applications. However, many basic aspects are still poorly understood, among which the problem of the dielectric constant stands out. Ferroelectric nematics exhibit giant dielectric constants whose value depends on the thickness of the measurement cell. Even though this must be the result of a spurious artifact, the intrinsic permittivity has not been determined yet. In this work, we tackle this problem by modeling the dielectric response of the liquid crystal filled cell through an equivalent circuit accounting for polarization reorientation and the effect of insulating interfacial layers. We arrive at the conclusion that the perpendicular component of the permittivity ε_{\perp} is of the order of 10 in the prototypical ferroelectric nematogen DIO, while the parallel component ε_{\parallel} is of the order of 150. In this way, the dielectric tensor of DIO has been fully determined.

* Corresponding author: aitor.erkorekap@ehu.eus

Materials with high permittivity have always garnered substantial interest due to their potential applications as capacitive elements in electronics, energy storage, sensors, actuators, etc. A high dielectric response is expected near the paraelectric-ferroelectric transition temperature in traditional ferroelectric materials [1]. However, since a few decades ago, materials with permittivity values exceeding 10^3 started to be reported to maintain this so-called “colossal” response on a wide temperature range showing a seemingly relaxational (and Arrhenius-like) behavior. The intrinsic nature of those colossal permittivity (CP) values was soon questioned and finally attributed to extrinsic effects stemming from electrode/sample interfaces or domain boundary effects (see, e.g., [2]). It is interesting to note that this does not hinder their usability in applications and it is still a very active field [3].

The recent discovery of the ferroelectric nematic phase (N_F) has sparked a new research area at the intersection of many disciplines such as soft matter, ferroelectrics and liquid crystal chemistry and physics. The interest is fueled by its unique fundamental properties and, again, potential impact in applications. Materials in the N_F phase exhibit polar properties comparable to those of solid ferroelectrics i.e., spontaneous polarization values ranging from $1\text{--}6\text{ }\mu\text{C}/\text{cm}^2$ [4–6], large nonlinear optical coefficients [7, 8] and also, very interestingly, CP effects [9–12], all with the added advantage of fluidity. The field is now at the stage of studying the origin of these properties, firstly, to understand the fundamental physics behind them and, secondly, to be able to design materials with tailored and improved characteristics for applications.

The origin of the CP in N_F materials is a subject of debate. Initially, it was attributed to the high polar ordering of the molecules in the N_F phase [5], and later more specifically described as collective relaxation phenomena [13]. However, large discrepancies among reported values hinted at the existence of some nonintrinsic conditions related to the measurements themselves such as the method, sample preparation, confinement conditions or even sample purity. This motivated a systematic study of the dielectric properties of the two prototypical N_F materials RM734 and DIO by our group as reported in references [14] and [15], respectively. In these works, a dependence of the complex permittivity $\varepsilon^*(\omega) = \varepsilon'(\omega) - i\varepsilon''(\omega)$ ($\omega = 2\pi f$ is the angular frequency) with the sample thickness in the N_F phase was clearly quantified. Furthermore, we proposed an interpretation of the observed relaxation processes in the entire phase sequence. In the N_F phase, the overwhelmingly dominant relaxation observed in both materials was a low-frequency ($\sim 10^3$ Hz) mode attributed to the collective

director orientation fluctuations, known as Goldstone mode.

Clark et al. proposed that, if the permittivity is measured in the typical parallel-plate configuration with the material planarly aligned so that the polarization \mathbf{P} lies parallel to the electrode surface (which is the configuration of minimum energy and observed experimentally), the reorientation of the large \mathbf{P} results in a near perfect cancelation of the applied field in the bulk leading to a very low effective resistance of the LC sample [16]. All the voltage drop occurs at the two nanometer-thick electrode interfacial layers acting as capacitors. What is measured is then a very large capacitance independent of the sample thickness that results in a very large and thickness dependent permittivity.

Recently, we noticed that suppressing the Goldstone mode in the N_F phase resulted in strikingly similar dielectric spectra in RM734 [14], DIO [15] and UUQU-4-N [17], regardless of the sample thickness. This can be seen in Fig. 1, where the permittivity of the three materials coalesces to a common value at low frequencies. This is to be expected, since the dipole moments of these molecules are very similar (DFT-calculated values are 11.4 D for RM734 and UUQU-4N, and 10.3 D for DIO). Thus, it follows that, as expected, measurements under a DC bias field strong enough to suppress polarization reorientation processes provide their actual dielectric spectra. In this case, the parallel component of the permittivity is probed, and a common value of $\epsilon_{\parallel} \approx 150$ can be estimated. As it can be seen in Fig. 1, it could be somewhat larger (≈ 200) for RM734, but one should note that in this material there is an increase in the real part of the permittivity at low frequencies due to electrode polarization effects. These values are compatible with those reported by Vaupotič et al. [13] for a RM734 homologue.

However, for a complete characterization of the uniaxial N_F phase, the parallel component of the permittivity ϵ_{\perp} is yet to be determined. As explained by Clark et al. (see Fig. 2), an externally applied electric field reorients the polarization vector, which is, as explained above, initially spatially homogeneous and parallel to the electrode plates, by an angle ψ (the Goldstone variable) [16]. In their words, this process charges the interfacial insulating layers of thickness d_i that bound the sample in typical measurement cells. These layers can be polyimide layers typically used to align liquid crystal molecules but, in cells with no alignment layers, they can also be liquid crystal molecules which cannot reorient due to surface pinning. The latter is the case in our experiments in which surface agents were not employed. The low-frequency dielectric response of such a cell can then be modeled as two

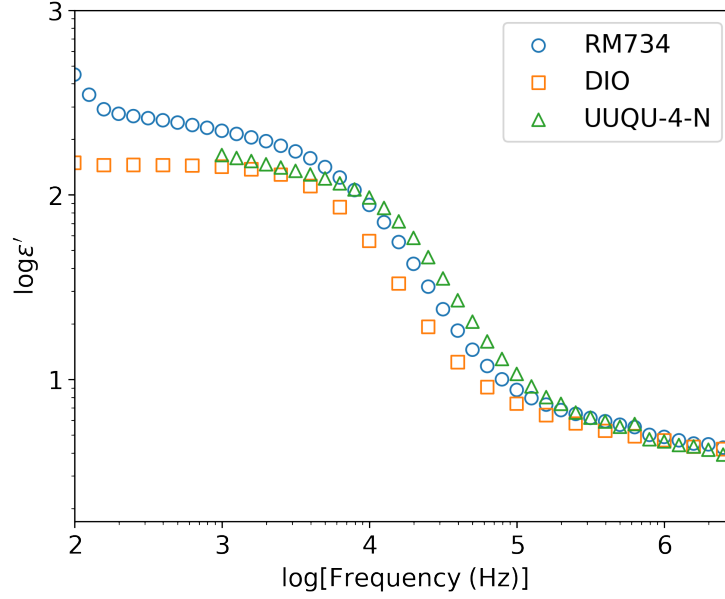


FIG. 1. Spectrum of the real component of the complex dielectric permittivity of RM734, DIO and UUQU-4-N in the N_F phase upon suppression of the Goldstone mode. These measurements correspond to 25, 5.1 and 30 μm -thick cells with 0.32, 1.10 and 0.27 $V_{DC}/\mu\text{m}$, respectively. Original data from Refs. [14, 15, 17].

series capacitors C_I associated with the insulating layers at each electrode in series with the LC sample modeled as a resistance R_{LC} in parallel with the capacitance of the liquid crystal CLC. In mathematical form, the complex impedance of the circuit and its relation with $\varepsilon^*(\omega)$ are:

$$Z^*(\omega) = \frac{2}{i\omega C_I} + \frac{1}{i\omega C_{LC} + \frac{1}{R_{LC}}} = \frac{d}{i\omega A \varepsilon_0 \varepsilon^*(\omega)}. \quad (1)$$

The capacitor C_{LC} contains its actual dielectric constant, while the resistance R_{LC} mainly accounts for the transport of bound charge due to the polarization reorientation, the resistivity being $\rho_{LC} = \gamma/P^2$ (γ is the rotational viscosity). Since the N_F phase is highly fluid and exhibits a large spontaneous polarization, both R_{LC} and ρ_{LC} are very low, effectively shorting the LC part of the circuit. In this case, the high-capacitance insulating layers would be measured, giving a large and thickness-dependent dielectric constant. As mentioned earlier, after our comprehensive dielectric study of three ferroelectric nematicogens, this is, in our view, the most feasible explanation for the large permittivity values. We now postulate

that, if this is indeed the case, it would be possible to estimate ε_{\perp} by fitting the dielectric spectroscopy data for cells with no alignment layers to the equivalent circuit of Fig. 2, and considering a reasonable value range for d_I . This is because, in that case, $\varepsilon_I = \varepsilon_{LC} = \varepsilon_{\perp}$ due to the molecules being pinned parallel to the electrodes.

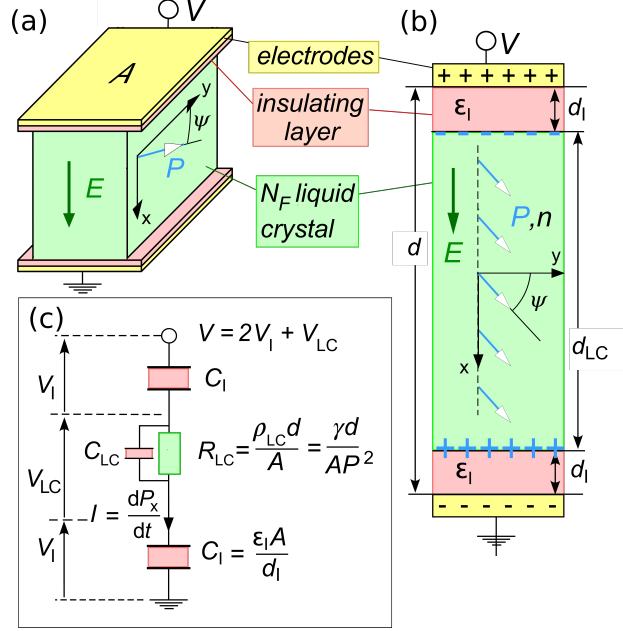


FIG. 2. (a), (b) Sketch of the typical measurement cell used in dielectric spectroscopy experiments. It is a parallel-plate capacitor of area A filled with the N_F material of thickness d_{LC} and bounded by two insulating interfacial layers of thickness d_I at the electrodes. When an electric field \mathbf{E} is applied across the cell, the polarization vector \mathbf{P} , which is initially spatially uniform and parallel to the plates, rotates through an angle ψ . This leads to the accumulation of bound charge at the insulating layers. Its low-frequency dielectric response can be modeled by the equivalent circuit shown in (c). Adapted from Ref. [16].

In order to test this idea, we have used the results of previously reported dielectric spectroscopy experiments performed on DIO [15] in which cells of various thicknesses were employed. In this material, the conductivity and electrode polarization are less prominent than in RM734 [14] for which a more complicated equivalent circuit would be necessary to fit the data, thereby complicating the analysis and obscuring the conclusions to be drawn. We have considered the data for the 14.7, 36 and 57 μm -thick cells, excluding the 5.1 μm -thick one because it is slightly affected by the cell relaxation at high-frequencies. We need

to fit the data for all thicknesses simultaneously, and require that the intrinsic material parameters ε_{LC} and ρ_{LC} be the same for all cells. The capacitance of the insulating layers is modeled as $C_I = C_0 df$ [12], where C_0 is the capacitance of the empty cell and d is the sample thickness, allowing $f = \varepsilon_I/d_I$ to change because, although we expect d_I to be similar for all cells, this quantity is determined by complex surface interactions and may slightly vary from cell to cell. First of all, we fitted the imaginary component of the permittivity, and we obtained $\rho_{LC} = 360 \text{ } \Omega \text{ m}$, while the fitting process forced $\varepsilon_{LC} \rightarrow 0$ independent of its starting value. This does not mean that $\varepsilon_{LC} = 0$ but that R_{LC} is so low (and $1/R_{LC}$ so large) that the $i\omega C_{LC}$ contribution is negligible, in accordance with the PCG model [16]. The fitted values for f are, as expected, similar: 2.2, 2.9 and 2.7 nm^{-1} in order of increasing thickness. To complete the analysis, the real component of the permittivity should also be considered. In this case, neglecting C_{LC} in light of the previous results and connecting a capacitance $C_\infty = C_0 \varepsilon_\infty$ in parallel to the circuit to account for the high-frequency dielectric constant, $\rho_{LC} = 340 \text{ } \Omega \text{ m}$ and $\varepsilon_\infty = 6$ is obtained, while $f = 2.1, 2.6$ and 2.5 nm^{-1} . These results prove the equivalence of both fits, which can be seen in Fig. 3. One further confirmation of the PCG mechanism can be obtained by comparing the fitted ρ_{LC} to the theoretical estimate. Taking $\gamma \approx 0.25 \text{ Pa s}$ and $P \approx 5 \text{ } \mu\text{C}/\text{cm}^2$ [18], $\rho_{LC} \approx 10^2 \text{ } \Omega \text{ m}$, which is of the same order of magnitude.

With this information we can already estimate ε_\perp . The average of f with the obtained values is $\sim 2.5 \text{ nm}^{-1}$. Considering a generous range for the insulating layer thickness d_I from 2–3 nm up to 10 nm, the possible values of ε_\perp would be in the range 6–25. The lower bound would mean that, aside from the Goldstone mode, there is no other underlying relaxation in the low-frequency range, while a higher value would imply a hidden relaxation process below 10^5 – 10^6 Hz . The estimated dielectric anisotropy is then $\delta\varepsilon = \varepsilon_\parallel - \varepsilon_\perp = 125$ – 144 . Thus, the dielectric anisotropy is positive, as expected from the molecular structure of DIO and ferroelectric nematogens in general, and large, due to its large dipole moment.

In this paper, we have once again ruled out the CP values of the N_F phase. This does not mean, however, that the N_F phase is insensitive to an externally applied electric field. Here we have followed the classical definition of permittivity, which does not include the spontaneous polarization. Mathematically, the total polarization in the i -th direction is the sum of the spontaneous and induced polarizations, namely $P_{\text{total},i} = P_i + \varepsilon_0(\varepsilon_{ij} - \delta_{ij})E_j$, where δ_{ij} is the Kronecker delta and summation over repeated indices is assumed. For practical

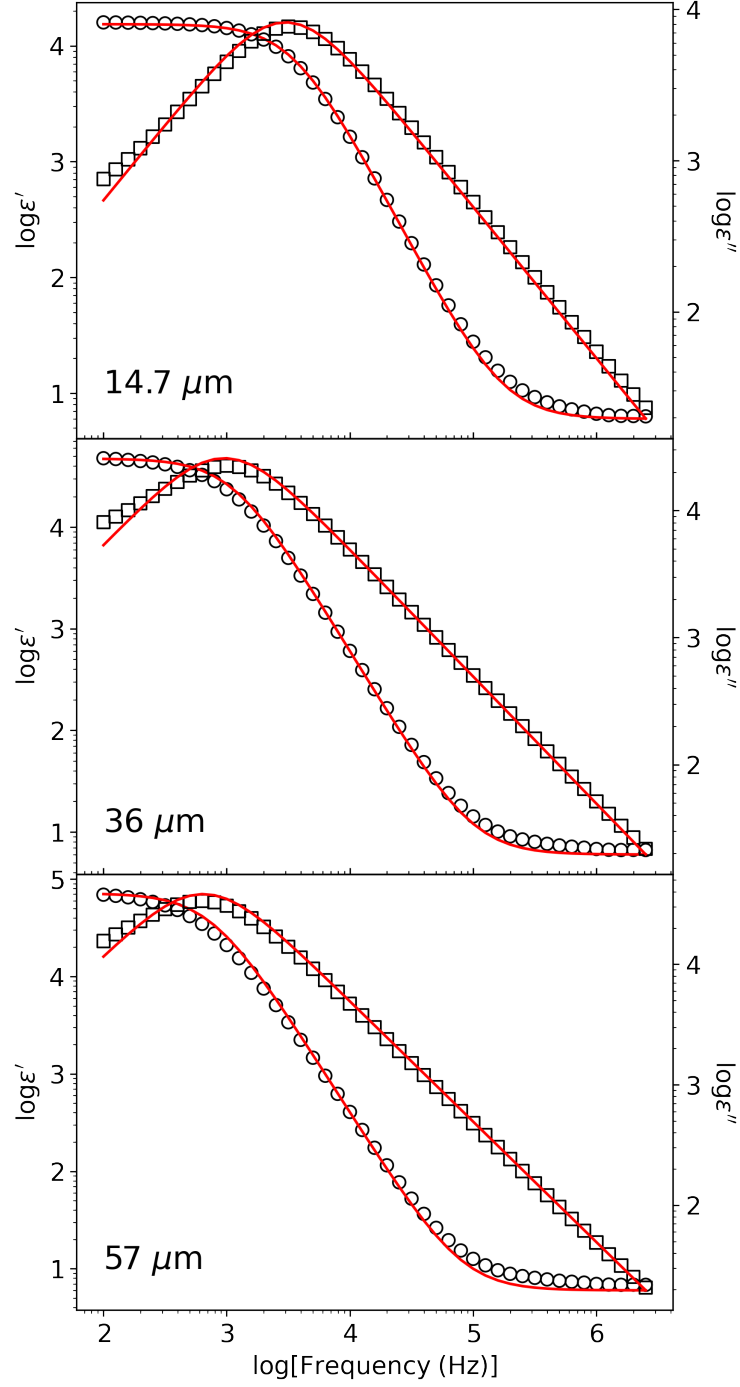


FIG. 3. Spectra of the real and imaginary components of the complex dielectric permittivity of DIO in the N_F phase (60°C) measured in 14.7, 36 and 57 μm -thick cells with their respective fits performed as explained in the text. Original data from Ref. [15].

applications involving polarization switching, the important term is the coupling between

the spontaneous polarization and the electric field (torque density $\tau = |\mathbf{P} \times \mathbf{E}|$). Since these materials have a large spontaneous polarization and are also highly fluid, this effect can be greatly exploited. Now that the two independent components of the dielectric tensor in the N_F phase have been estimated, it would be of utmost interest to seek a theoretical model, analogous to Maier–Meier theory [19], that can predict these values from molecular/structural parameters in order to obtain a complete microscopic understanding of the phase. To this end, it is also crucial to maintain ongoing experimental research so as to discriminate between the particular properties of the different compounds and the universal properties of the phase itself. In terms of the method used in this work, it would also be helpful to somehow improve the estimate d_l in order to reduce the lower and upper bounds of ε_\perp .

ACKNOWLEDGEMENTS

We would like to thank M. Huang, S. Aya, R.J. Mandle, N. Sebastián and A. Mertelj for letting us use the dielectric data from previous common research works. A.E. and J.M.-P. acknowledge funding from the Basque Government Project IT1458-22. A.E. thanks the Department of Education of the Basque Government for a predoctoral fellowship (grant number PRE_2023_2_0113).

-
- [1] C. Kittel, *Introduction to solid state physics*, 8th ed. (John Wiley & Sons, Nashville, TN, 2004).
 - [2] P. Lunkenheimer, R. Fichtl, S. G. Ebbinghaus, and A. Loidl, Nonintrinsic origin of the colossal dielectric constants in $\text{CaCu}_3\text{Ti}_4\text{O}_{12}$, *Phys. Rev. B* **70**, 172102 (2004).
 - [3] Y. Wang, W. Jie, C. Yang, X. Wei, and J. Hao, Colossal permittivity materials as superior dielectrics for diverse applications, *Advanced Functional Materials* **29**, 1808118 (2019).
 - [4] X. Chen, E. Korblova, D. Dong, X. Wei, R. Shao, L. Radzihovsky, M. A. Glaser, J. E. MacLennan, D. Bedrov, D. M. Walba, and N. A. Clark, First-principles experimental demonstration of ferroelectricity in a thermotropic nematic liquid crystal: Polar domains and striking electro-optics, *Proceedings of the National Academy of Sciences* **117**, 14021 (2020).

- [5] H. Nishikawa, K. Shiroshita, H. Higuchi, Y. Okumura, Y. Haseba, S.-i. Yamamoto, K. Sago, and H. Kikuchi, A fluid liquid-crystal material with highly polar order, *Advanced Materials* **29**, 1702354 (2017).
- [6] S. Brown, E. Cruickshank, J. M. D. Storey, C. T. Imrie, D. Pociecha, M. Majewska, A. Makal, and E. Gorecka, Multiple polar and non-polar nematic phases, *ChemPhysChem* **22**, 2506 (2021).
- [7] C. L. Folcia, J. Ortega, R. Vidal, T. Sierra, and J. Etxebarria, The ferroelectric nematic phase: an optimum liquid crystal candidate for nonlinear optics, *Liquid Crystals* **49**, 899 (2022).
- [8] R. Xia, X. Zhao, J. Li, H. Lei, Y. Song, W. Peng, X. Zhang, S. Aya, and M. Huang, Achieving enhanced second-harmonic generation in ferroelectric nematics by doping d- π -a chromophores, *J. Mater. Chem. C* **11**, 10905 (2023).
- [9] A. Manabe, M. Bremer, and M. Kraska, Ferroelectric nematic phase at and below room temperature, *Liquid Crystals* **48**, 1079 (2021).
- [10] R. J. Mandle, N. Sebastián, J. Martinez-Perdiguero, and A. Mertelj, On the molecular origins of the ferroelectric splay nematic phase, *Nature Communications* **12**, 4962 (2021).
- [11] J. Li, H. Nishikawa, J. Kougo, J. Zhou, S. Dai, W. Tang, X. Zhao, Y. Hisai, M. Huang, and S. Aya, Development of ferroelectric nematic fluids with giant- ϵ dielectricity and nonlinear optical properties, *Science Advances* **7**, eabf5047 (2021).
- [12] V. Matko, E. Gorecka, D. Pociecha, J. Matraszek, and N. Vaupotič, Do ferroelectric nematic liquid crystals really have a huge dielectric permittivity? (2024), arXiv:2401.16084 [cond-mat.soft].
- [13] N. Vaupotič, D. Pociecha, P. Rybak, J. Matraszek, M. Čepič, J. M. Wolska, and E. Gorecka, Dielectric response of a ferroelectric nematic liquid crystalline phase in thin cells, *Liquid Crystals* , 1 (2023).
- [14] A. Erkoreka, J. Martinez-Perdiguero, R. J. Mandle, A. Mertelj, and N. Sebastián, Dielectric spectroscopy of a ferroelectric nematic liquid crystal and the effect of the sample thickness, *Journal of Molecular Liquids* **387**, 122566 (2023).
- [15] A. Erkoreka, A. Mertelj, M. Huang, S. Aya, N. Sebastián, and J. Martinez-Perdiguero, Collective and non-collective molecular dynamics in a ferroelectric nematic liquid crystal studied by broadband dielectric spectroscopy, *The Journal of Chemical Physics* **159**, 184502 (2023).

- [16] N. A. Clark, X. Chen, J. E. MacLennan, and M. A. Glaser, Dielectric spectroscopy of ferroelectric nematic liquid crystals: Measuring the capacitance of insulating interfacial layers, *Phys. Rev. Res.* **6**, 013195 (2024).
- [17] A. Erkoreka, N. Sebastián, A. Mertelj, and J. Martinez-Perdiguero, A molecular perspective on the emergence of long-range polar order from an isotropic fluid, (To be published).
- [18] X. Chen, Z. Zhu, M. J. Magrini, E. Korblova, C. S. Park, M. A. Glaser, J. E. MacLennan, D. M. Walba, and N. A. Clark, Ideal mixing of paraelectric and ferroelectric nematic phases in liquid crystals of distinct molecular species, *Liquid Crystals* **49**, 1531 (2022).
- [19] W. Maier and G. Meier, Eine einfache theorie der dielektrischen eigenschaften homogen orientierter kristallinflüssiger phasen des nematischen typs, *Zeitschrift für Naturforschung A* **16**, 262 (1961).